## Application/Control No. Applicant(s)/Patent Under Reexamination 09/903,215 DE LEON ET AL. Notice of References Cited **Art Unit** Examiner Page 1 of 1 1771 John J. Guarriello **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,321,425 11-2001 PUTNAM ET AL. 1999 28/104 Α US-В US-С D US-US-E F US-US-G Н US-1 US-J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Country Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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